SHEET 1 OF 1

INFORMATION DISCLOSURE CITATION IN AN APPLICATION						ATTY. DOCKET NO. 57454-982	SERIAL NO. 10/686,766				
						APPLICANT Tadatoshi SUZUKI, et al.					
(PTO-1449)						FILING DATE GROUP 3748					
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE SERIAL NO. ATTY. DOCKET NO. 10/686,766 57454-982 CITATION IN AN APPLICATION APPLICANT Tadatoshi SUZUKI, et al. GROUP **FILING DATE** (PTO-1449) 3748 October 17, 2003 **U.S. PATENT DOCUMENTS** Pages, Columns, Lines, Where **EXAMINER'S** Publication Date Name of Patentee or Applicant of Cited Document Number MM-DD-YYYY Document Relevant Passages or Relevant INITIALS CITE Number-Kind Code2 (# known) Figures Appear 5,375,323 12/27/1994 Sata us 5,427,457 06/27/1995 Furumura et al. 10/10/1995 Yamashita et al. US 5,456,136 US 5,611,250 03/18/1997 Narai et al. Takemura et al. R1 US 6,224,688 05/01/2001 US US US US US US US บร US FOREIGN PATENT DOCUMENTS Translation **Publication Date** Name of Patentee or Pages, Columns, Lines **EXAMINER'S** Foreign Patent Document Applicant of Cited Document Where Relevant INITIALS CITE Country Code3 -Number 4 -Kind Code5 (if known) MM-DD-YYYY Figures Appear No Yes Koyo Seiko Co., Ltd. A1 EP 0 811 789 12/10/1997 EP 0 950 723 10/20/1999 Komatsu Ltd. A1 NSK Ltd. GB 2 258 274 02/03/1993 Α OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), of the item (book, magazine. **EXAMINER'S** journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where INITIALS CITE published. . DATE CONSIDERED EXAMINER

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				APPLICANT Tadatoshi SUZUKI, et al.					
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